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Pulse-LINK Selects Verigy Test Platform For High-Speed UWB Devices

Cupertino, CA - Verigy recently announced that Pulse~LINK has selected the Verigy V93000 as the preferred test platform for its CWave UWB devices. Verigy worked together with DA-Test, a semiconductor test service provider, to propose and implement the successful solution for Pulse~LINK's CWave UWB chipset.

Pulse~LINK's technology recently received two International Consumer Electronics Show (CES) Innovations Design and Engineering awards and was chosen by Popular Mechanics for the 2008 "Editor's Choice" award at CES in Las Vegas earlier this month. Additionally, DA-Test and Pulse~LINK were recognized by their peers with a Best Paper award at VOICE 2007, Verigy's second annual Users and Partners Conference in San Jose, Dec. 2007, for the paper they presented on this work.

"In order to continue to lead the industry with high-performance UWB silicon for high data rate connectivity, Pulse~LINK requires test solutions that can meet the unprecedented performance of the CWave chipset," said Raj Sengottaiyen, VP of Engineering, Pulse~LINK. Andy Chiang, Senior Test Engineer at Pulse~LINK, continued, "The Gbps and multi-port capabilities of the V93000 channels are a perfect match with the test requirements of our CWave UWB transceiver. Working with DA-Test and Verigy allowed us to develop a high quality, cost effective test solution."

"The open design of the V93000 platform allows our customers flexibility in using outsource service providers. Our partnership with DA-Test has proven extremely productive for our joint customers, like Pulse~LINK, who are pushing the boundaries of RF and wireless technology," said Pascal Ronde, Vice President of Sales, Service and Support, Verigy. "This project typifies the challenge and excitement of our role in supporting semiconductor innovation."

"The recognition received by our VOICE paper confirmed that there's a lot of interest in solutions to UWB transceiver test," said Scott Bulbrook, VP of Engineering, DA-Test. "We are pleased to have the opportunity to work with Verigy and Pulse~LINK to develop the complex solution required for the necessary test coverage."

About DA-Test

DA-Test delivers a comprehensive range of IC Test related Technology and Services, tailored to match Customer requirements. Services include: ATE Test Solution Development, Test Related Design Services, Test Operations, Product Engineering Services, and Test Technology Development. Its Test and Design Engineering Team serves its customers with a unique combination of expertise, best in class tools and software. More information on DA-Test is available at www.da-test.com.

SOURCE: Verigy